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United States Patent [19]

Narayanan

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[54] TEST INSTRUMENT FOR MEASURING PROPERTIES OF LIQUIDS

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[**] Term: 14 Years
[21] Appl. No.: 922,968

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D24/231, 232

[56] References Cited

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Cole-Palmer Catalog 1987-1988, pp. 138, 147, 435, 442-444, 822 832.

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[57] CLAIM

The ornamental design for test instrument for measuring properties of liquids, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of a test instrument for measuring properties of liquids showing my new design;

FIG. 2 is a front elevational view thereof;

FIG. 3 is a rear elevational view thereof;

FIG. 4 is a top plan view thereof;

FIG. 5 is a bottom plan view thereof;

FIG. 6 is a right hand side elevational view thereof; FIG. 7 is a left hand side elevational view thereof;

FIG. 8 is a perspective view thereof showing a protec-

tive cover in place over a lower portion thereof;

FIG. 9 is a perspective view of a test instrument for measuring properties of liquids showing a second embodiment of my new design;

FIG. 10 is a front elevational view thereof;

FIG. 11 is a rear elevational view thereof;

FIG. 12 is a top plan view thereof;

FIG. 13 is a bottom plan view thereof;

FIG. 14 is a right hand side elevational view thereof;

FIG. 15 is a left hand elevational view thereof;

FIG. 16 is a perspective view thereof showing a cap in

place over the bottom thereof;

FIG. 17 is a perspective view of a test instrument for measuring properties of liquids in accordance with a third embodiment of my new design having a probe extending downward from the bottom thereof;

FIG. 18 is a front elevational view thereof;

FIG. 19 is a rear elevational view thereof;

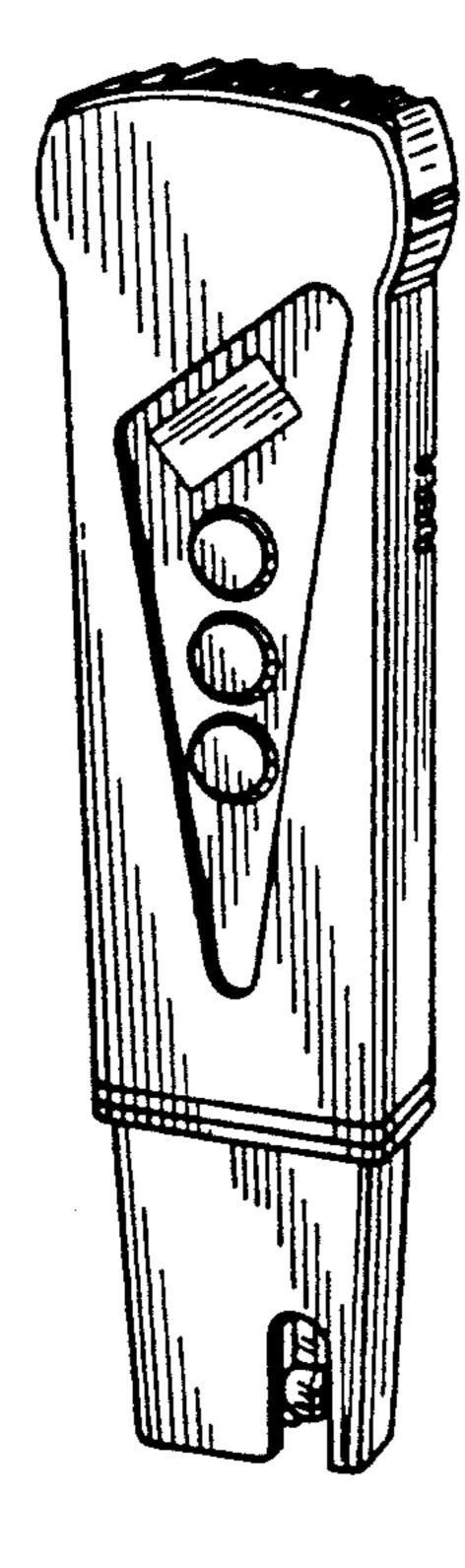
FIG. 20 is a right hand side elevational view thereof;

FIG. 21 is a left hand side elevational view thereof;

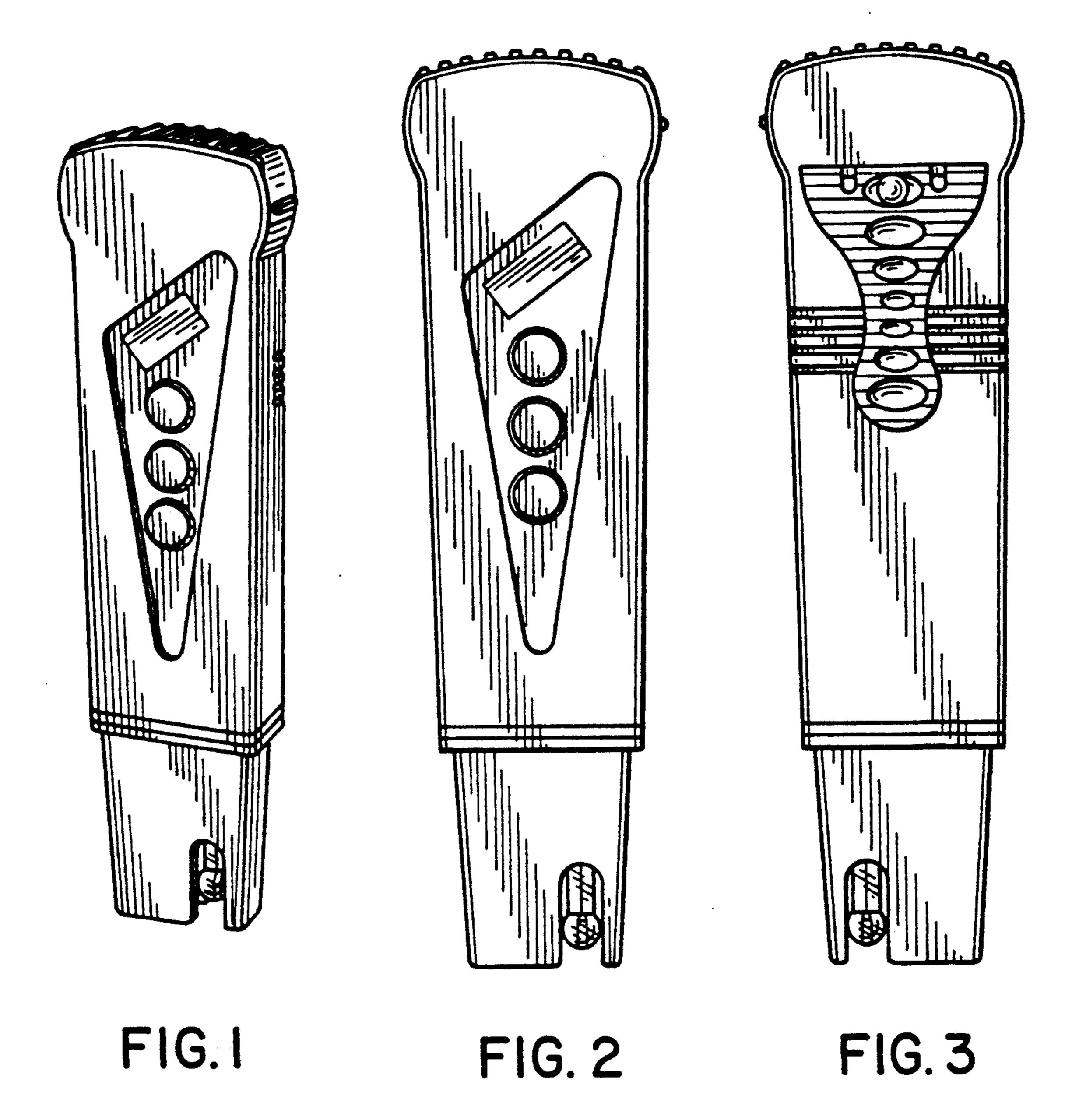
FIG. 22 is a top plan view thereof; and

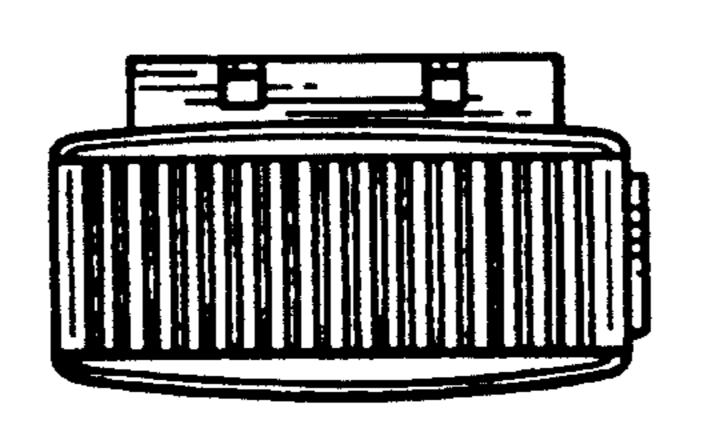
FIG. 23 is a bottom plan view thereof.

The cover has been removed for ease of illustration in all views except FIGS. 8 and 16.



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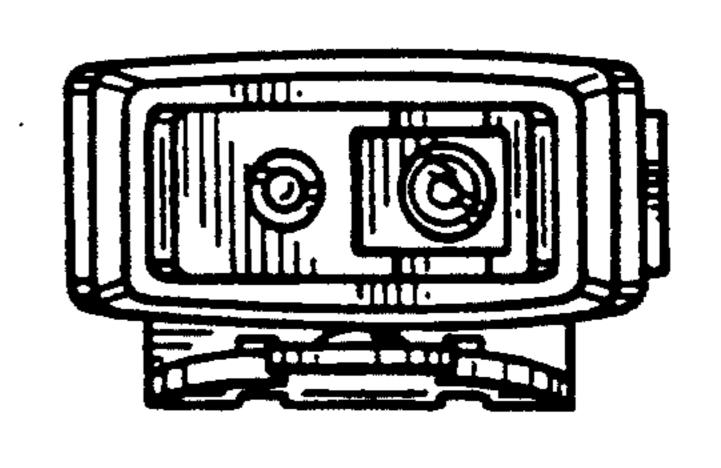
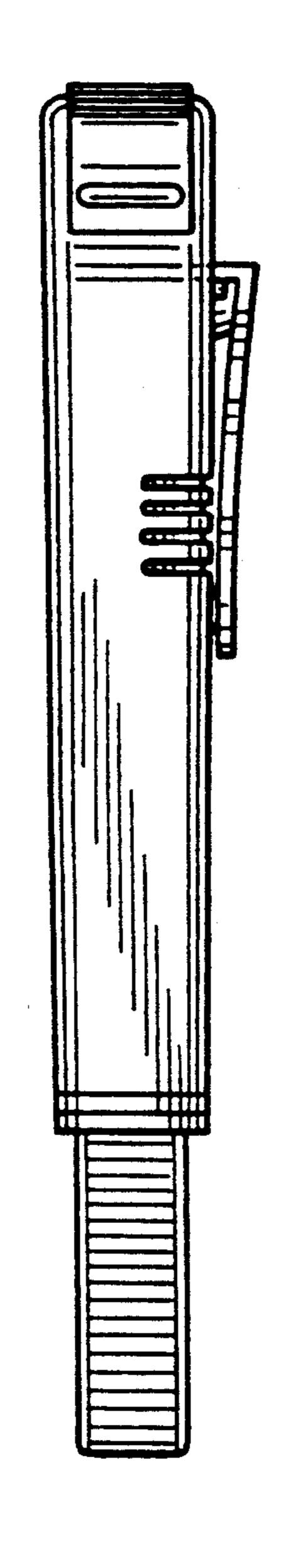
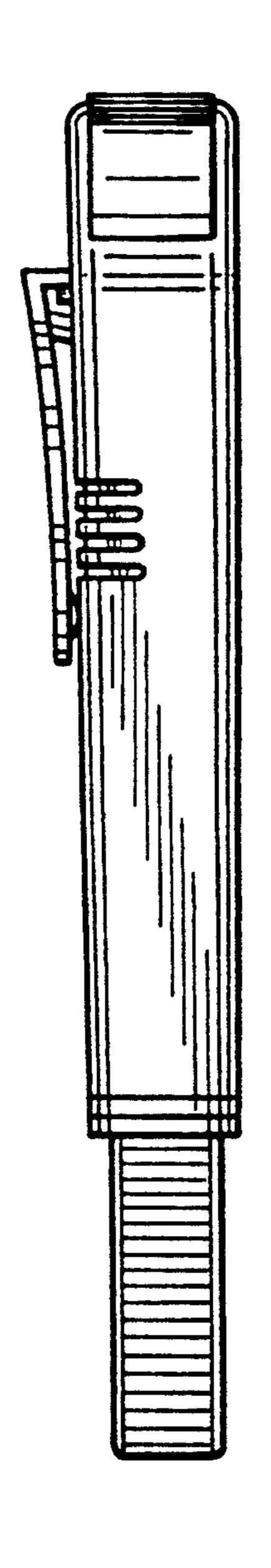


FIG. 5



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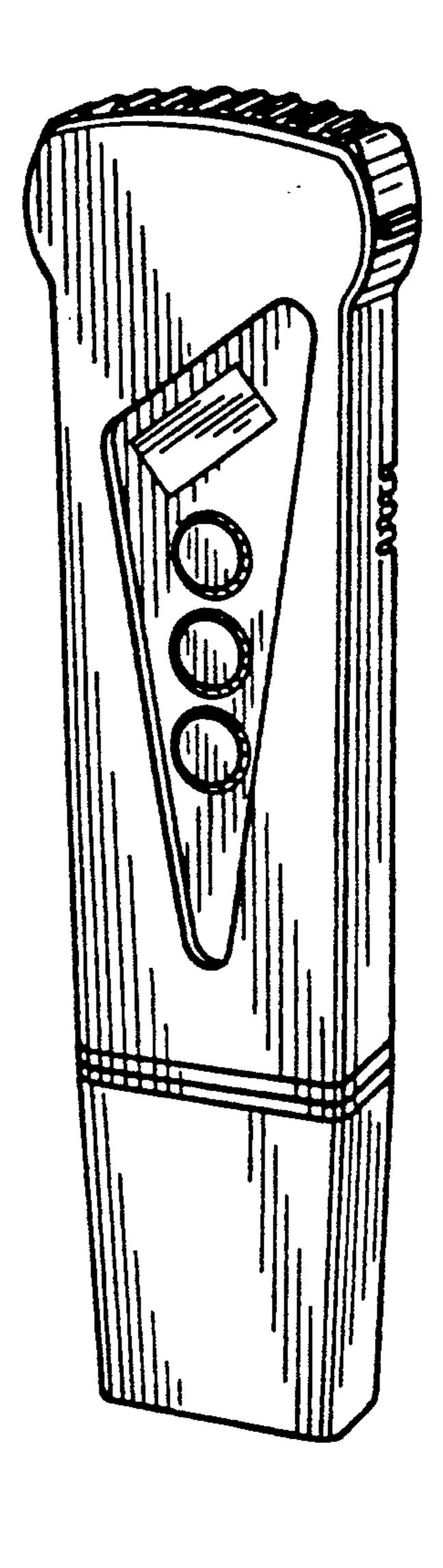


FIG. 6

FIG. 7

FIG. 8

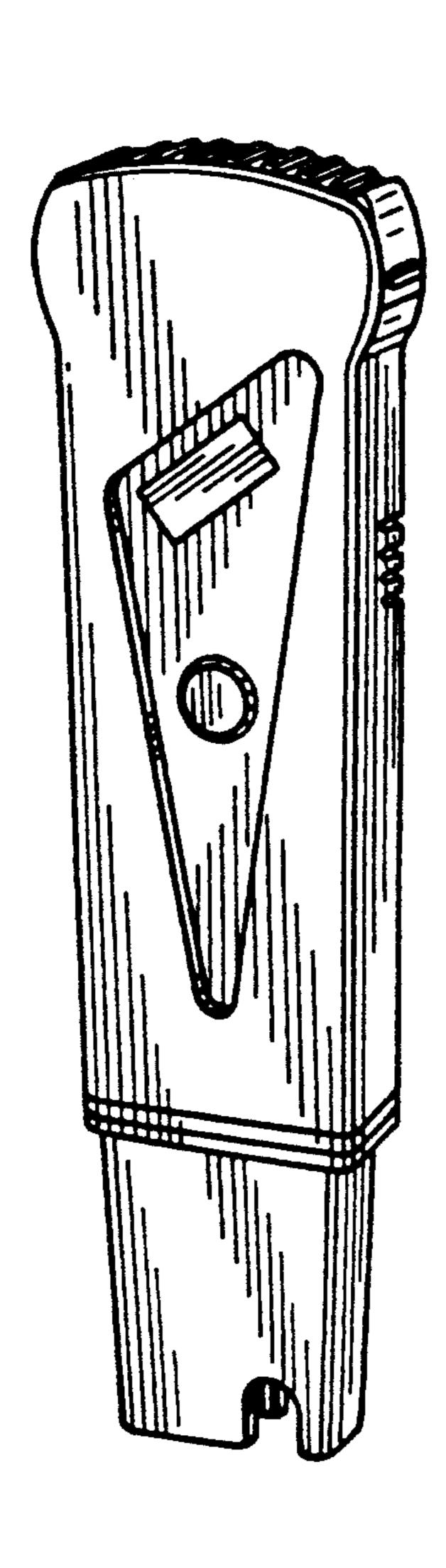


FIG. 9

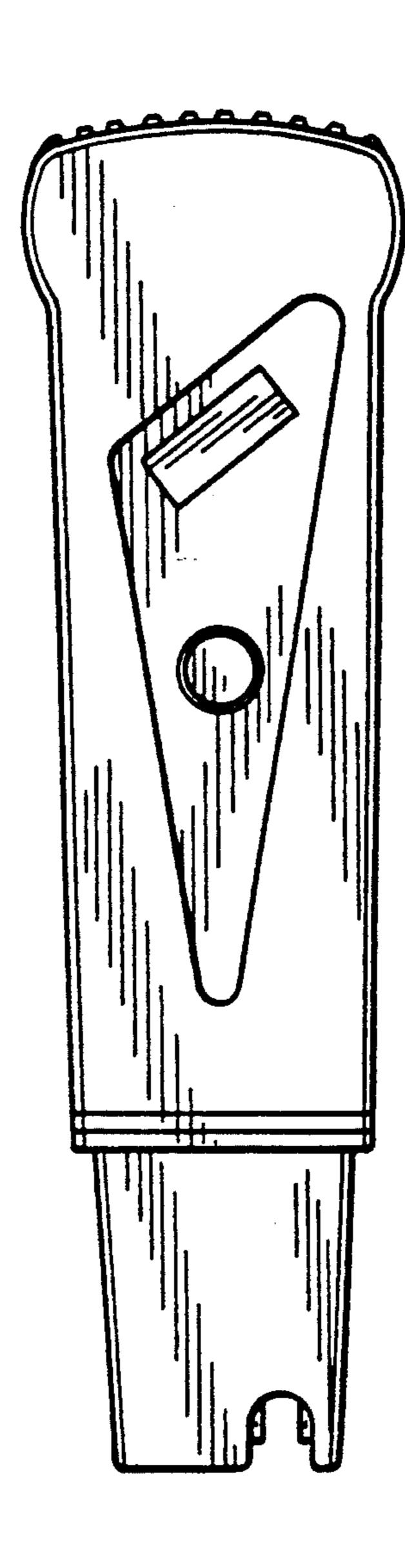


FIG. 10

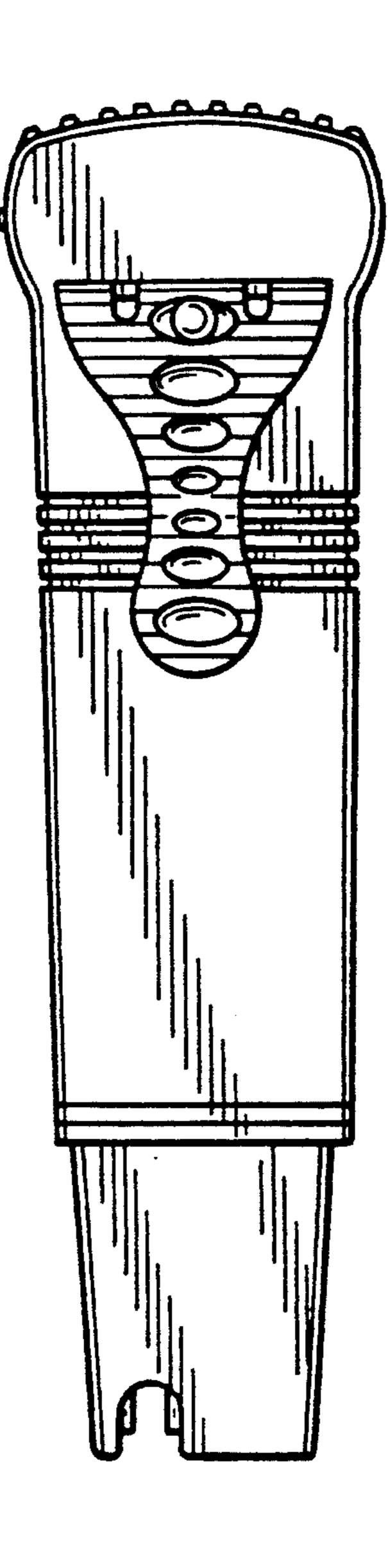


FIG. II

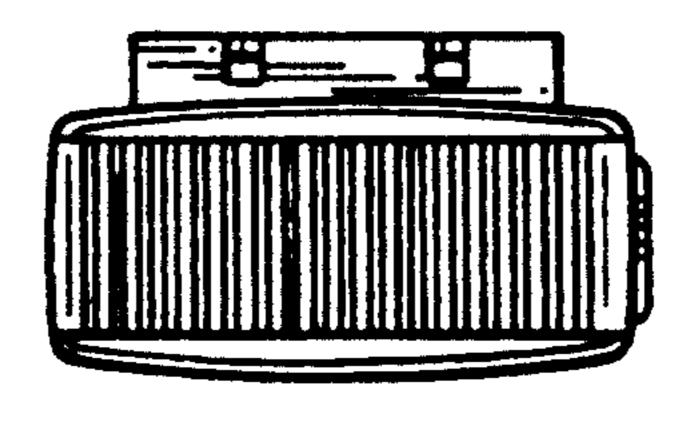


FIG.12

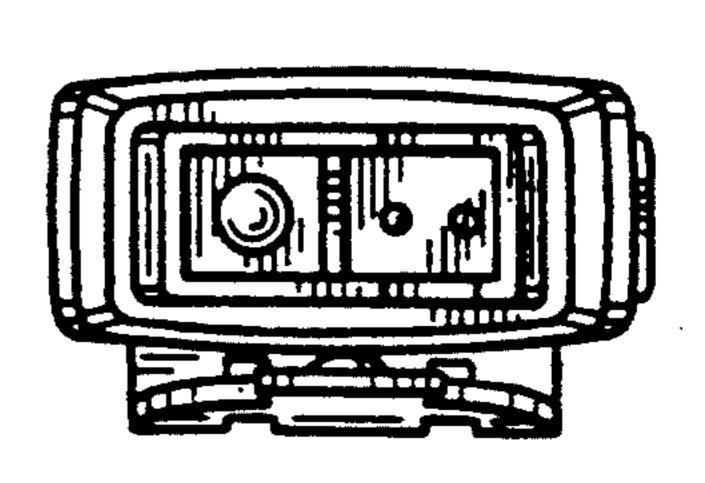
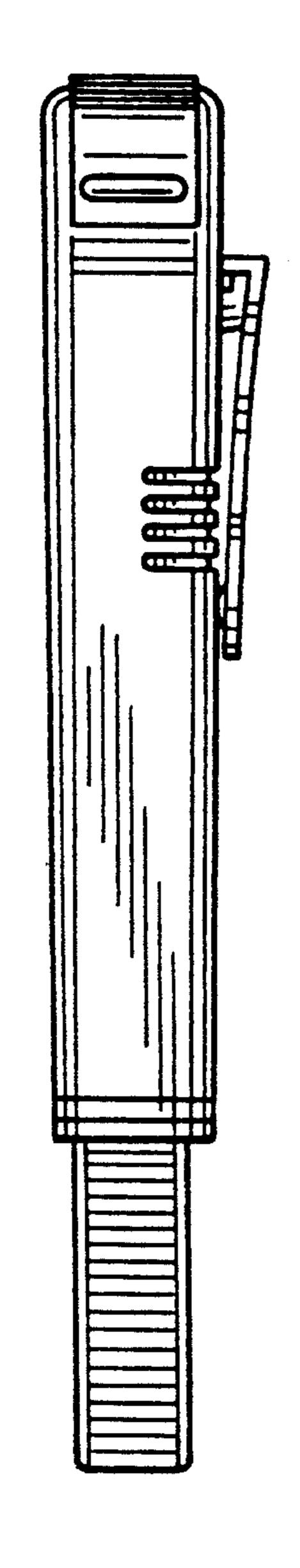
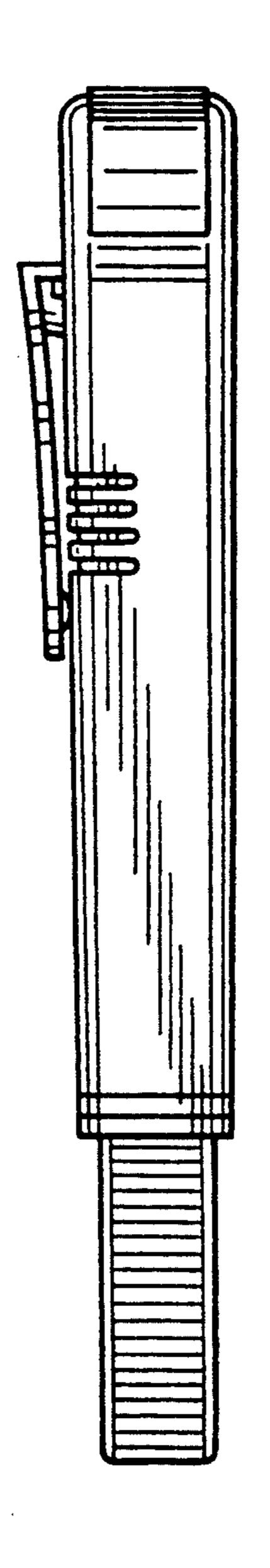


FIG. 13



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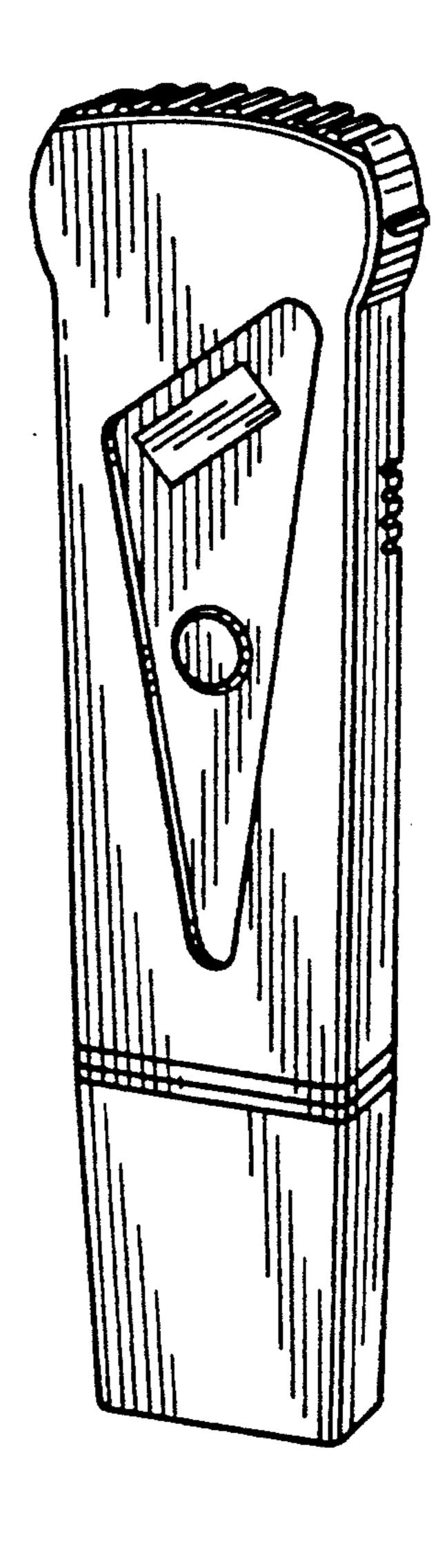


FIG.14

F1G. 15

F1G. 16

